

MOSFET - N-Channel QFET®

60 V, 2.8 A, 140 m Ω

FQT13N06

Description

This N-Channel enhancement mode power MOSFET is produced using **onsemi**'s proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, audio amplifier, DC motor control, and variable switching power applications.

Features

- 2.8 A, 60 V, $R_{DS(on)}$ = 140 m Ω (Max) @ V_{GS} = 10 V, I_D = 1.4 A
- Low Gate Charge (Typ. 5.8 nC)
- Low Crss (Typ. 15 pF)
- 100% Avalanche Tested
- This is a Pb-Free Device

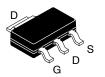
ABSOLUTE MAXIMUM RATINGS

 $(T_C = 25^{\circ}C \text{ unless otherwise noted})$

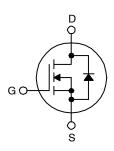
Symbol	Parameter		Value	Unit
V _{DSS}	Drain to Source Voltage		60	V
Ι _D	Drain Current Continuous (T _C = 25°C) Continuous (T _C = 70°C)		2.8 2.24	Α
I _{DM}	Drain Current - Pulsed	(Note 1)	11.2	Α
V _{GSS}	Gate to Source Voltage		±25	V
E _{AS}	Single Pulsed Avalanche Energy	y (Note 2)	85	mJ
I _{AR}	Avalanche Current	(Note 1)	2.8	Α
E _{AR}	Repetitive Avalanche Energy	(Note 1)	0.21	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	7.0	V/ns
P _D	Power Dissipation (T _C = 25°C) Derate above 25°C		2.1 0.017	W W/°C
T _J , T _{STG}	Operating and Storage Temperature Range		–55 to +150	°C
T _L	Maximum Lead Temperature for Soldering Purposes, 1/8" from Case for 5 Seconds		300	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 2. L = 12.6 mH, I_{AS} = 2.8 A, V_{DD} = 25 V, R_G = 25 Ω , Starting T_J = 25°C.
- 3. $I_{SD} \le 13$ A, $di/dt \le 300$ A/ μ s, $V_{DD} \le BV_{DSS}$, Starting $T_J = 25^{\circ}C$.



SOT-223 CASE 318H-01



MARKING DIAGRAM



A = Assembly Location

Y = Year W = Work Week

FQT13N06TF = Specific Device Code

= Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

Device	Package	Shipping [†]
FQT13N06TF	SOT-223 (Pb-Free)	4000 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

THERMAL CHARACTERISTICS

Symbol	Parameter	Min	Max	Unit
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient*	-	60	°C/W

^{*}When mounted on the minimum pad size recommended (PCB Mount)

$\textbf{ELECTRICAL CHARACTERISTICS} \quad (T_C = 25 ^{\circ}C, \text{ unless otherwise noted})$

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
OFF CHAR	ACTERISTIC					<u>.</u>
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	60	_	-	V
ΔBV _{DSS} /ΔT _J	Breakdown Voltage Temperature Coefficient	I _D = 250 μA, Referenced to 25°C	-	0.6	-	V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 60 V, V _{GS} = 0 V	-	-	1	μΑ
		V _{DS} = 48 V, T _C = 150°C	-	-	10	
I _{GSSF}	Gate to Body Leakage Current, Forward	V _{GS} = 25 V, V _{DS} = 0 V	-	-	100	nA
I _{GSSR}	Gate to Body Leakage Current, Reverse	V _{GS} = -25 V, V _{DS} = 0 V	-	-	-100	
ON CHARA	CTERISTICS					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$	2.0	-	4.0	V
R _{DS(on)}	Static Drain to Source On-Resistance	V _{GS} = 10 V, I _D = 1.4 A	-	0.11	0.14	Ω
9FS	Forward Transconductance	V _{DS} = 25 V, I _D = 1.4 A (Note 4)	-	3.0	-	S
DYNAMIC (CHARACTERISTICS			•	•	
C _{iss}	Input Capacitance	V _{DS} = 25 V, V _{GS} = 0 V, f = 1.0 MHz	-	240	310	pF
C _{oss}	Output Capacitance	1 1	-	90	120	pF
C _{rss}	Reverse Transfer Capacitance	1	-	15	20	pF
SWITCHING	G CHARACTERISTICS					
t _{d(on)}	Turn-On Delay Time	V_{DD} = 30 V, I_D = 6.5 A, R_G = 25 Ω	-	5	20	ns
t _r	Turn-On Rise Time	(Note 4 and 5)	-	25	60	ns
t _{d(off)}	Turn-Off Delay Time]	-	8	25	ns
t _f	Turn-Off Fall Time	1 1	-	15	40	ns
Qg	Total Gate Charge	V _{DS} = 48 V, I _D = 13 A, V _{GS} = 10 V	-	5.8	7.5	nC
Q _{gs}	Gate to Source Charge	(Note 4 and 5)	-	2.0	-	nC
Q _{gd}	Gate to Drain Charge	1 1	-	2.5	-	nC
DRAIN-SO	URCE DIODE CHARACTERISTICS AND M	AXIMUM RATINGS				
I _S	Maximum Continuous Drain to Source Diode Forward Current		-	-	2.8	Α
I _{SM}	Maximum Pulsed Drain to Source Diode Forward Current		-	-	11.2	Α
V _{SD}	Drain to Source Diode Forward Voltage	V _{GS} = 0 V, I _S = 2.8 A	-	-	1.5	V
t _{rr}	Reverse Recovery Time	$V_{GS} = 0 \text{ V, } I_S = 13 \text{ A, } dI_F/dt = 100 \text{ A/}\mu\text{s}$	-	39	-	ns
Q _{rr}	Reverse Recovery Charge	(Note 4)	-	40	-	μC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Pulse Test: Pulse width $\leq 300 \,\mu$ s, Duty Cycle $\leq 2\%$.

^{5.} Essentially Independent of Operating Temperature.

TYPICAL CHARACTERISTICS

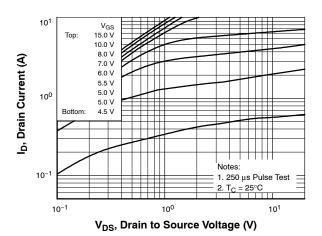


Figure 1. On-Region Characteristics

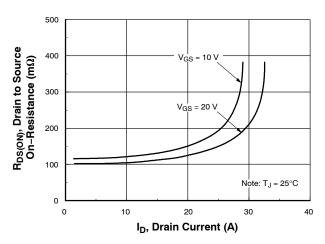


Figure 3. On-Resistance Variation vs.
Drain Current and Gate Voltage

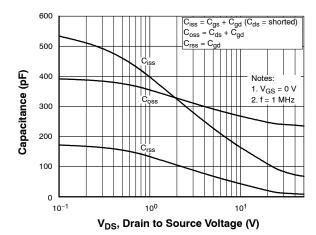


Figure 5. Capacitance Characteristics

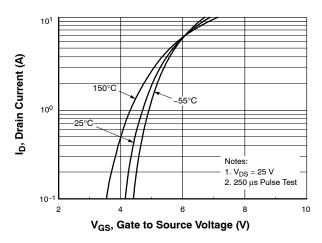


Figure 2. Transfer Characteristics

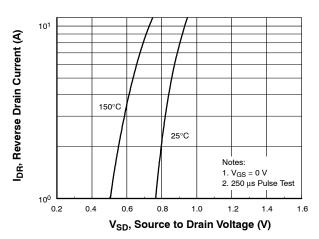


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

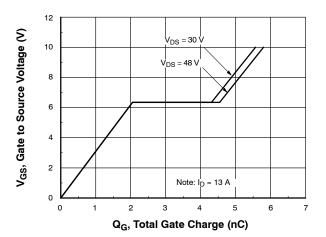


Figure 6. Gate Charge Characteristics

TYPICAL CHARACTERISTICS (Continued)

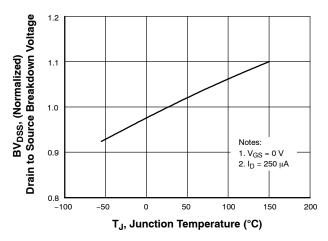


Figure 7. Breakdown Voltage Variation vs. Temperature

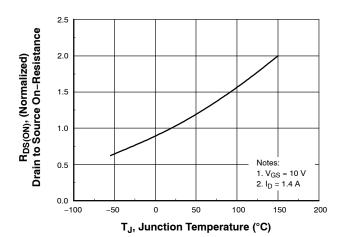


Figure 8. On–Resistance Variation vs. Temperature

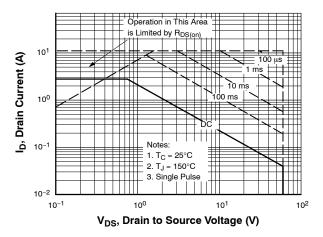


Figure 9. Maximum Safe Operating Area

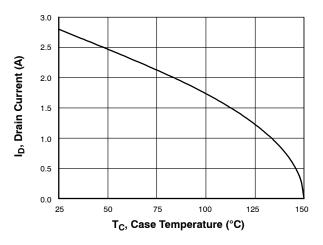


Figure 10. Maximum Drain Current vs. Case Temperature

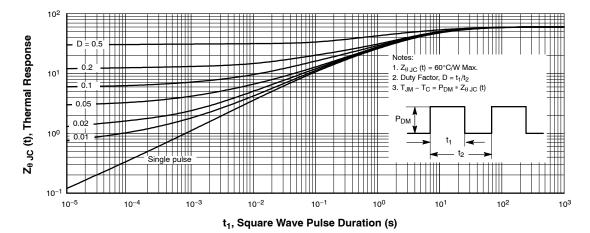


Figure 11. Transient Thermal Response Curve

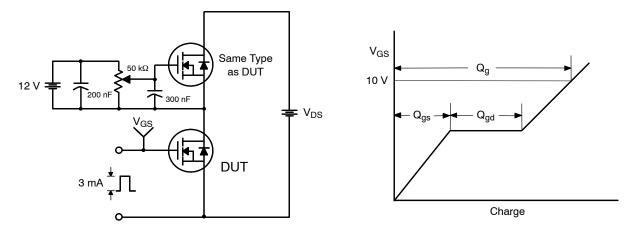


Figure 12. Gate Charge Test Circuit & Waveform

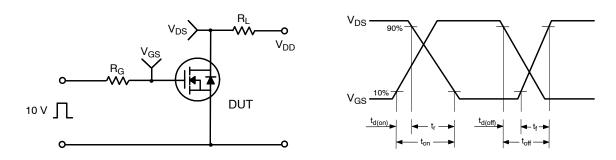


Figure 13. Resistive Switching Test Circuit & Waveforms

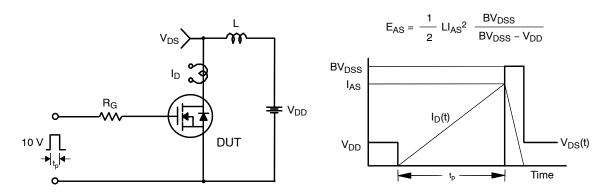
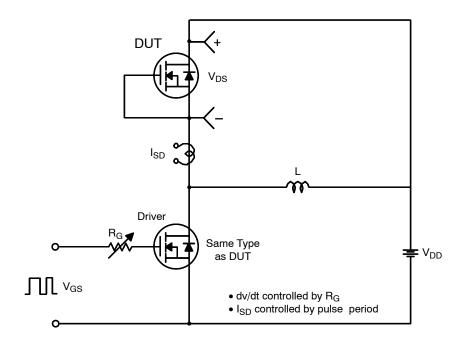


Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms



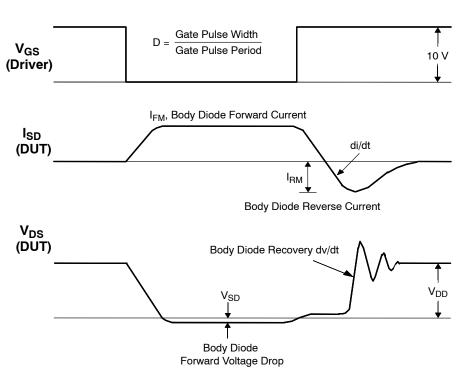


Figure 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms

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SCALE 2:1

|△|0.10|C



A

В

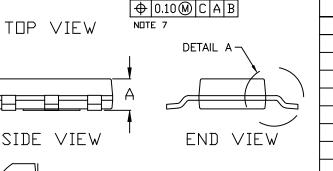
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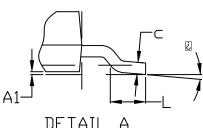
NOTES

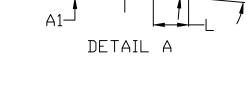
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 Y14.5M, 2009.
 CONTROLLING DIMENSION: MILLIMETERS
 DIMENSIONS D & E1 ARE DETERMINED AT DATUM
 H. DIMENSIONS DO NOT INCLUDE MOLD FLASH,
 PROTRUSIONS DR GATE BURRS. SHALL NOT
 EXCEED 0.23mm PER SIDE.
 LEAD DIMENSIONS & AND &1 DO NOT INCLUDE
 DAMBAR PROTRUSION. ALLOWABLE DAMBBAR
 PROTRUSION IS 0.08mm PER SIDE.
 DATUMS A AND B ARE DETERMINED AT DATUM H.
 A1 IS DEFINED AS THE VERTICAL DISTANCE
 FROM THE SEATING PLANE TO THE LOWEST
 POINT OF THE PACKAGE BODY.
 POSITIONAL TOLERANCE APPLIES TO DIMENSIONS
 & AND &1.

- b AND b1.

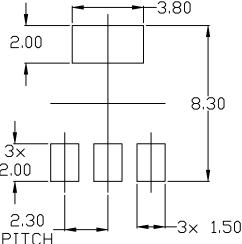
	111 L TUETEDO				
	MILLIMETERS				
DIM	MIN.	N□M.	MAX.		
Α		-	1.80		
A1	0.02	0.06	0.11		
b	0.60	0.74	0.88		
b1	2.90	3.00	3.10		
С	0.24		0.35		
D	6.30	6.50	6.70		
E	6.70	7.00	7.30		
E1	3.30	3.50	3.70		
е	2.30 BSC				
L	0.25				
į.	0*		10°		







3x2.00 2,30



GENERIC MARKING DIAGRAM*

AYW XXXXX. = Assembly Location

= Year W

= Work Week XXXXX = Specific Device Code

= Pb-Free Package

(Note: Microdot may be in either location)

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

RECOMMENDED MOUNTING FOOTPRINT

For additional information on our Pb-Free strategy and soldering details, please download the IIN Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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DESCRIPTION:	SOT-223		PAGE 1 OF 1	

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